

Application/Control No.	Applicant(s)/Patent under Reexamination
10/510,371	PETEREIT ET AL.
Examiner	Art Unit
Michael Bernshteyn	1713

SEARCHED				
Class	Subclass	Date	Examiner	
526	319	2/27/2006	МВ	
526	317.1	2/27/2006	МВ	
526	328	2/27/2006	МВ	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPAT, JPO, EPO,DERWENT, PREGRANT	2/27/2006	МВ
PALM, eDAN Inventors and Assignee search update	2/27/2006	МВ
NPL	2/27/2006	МВ